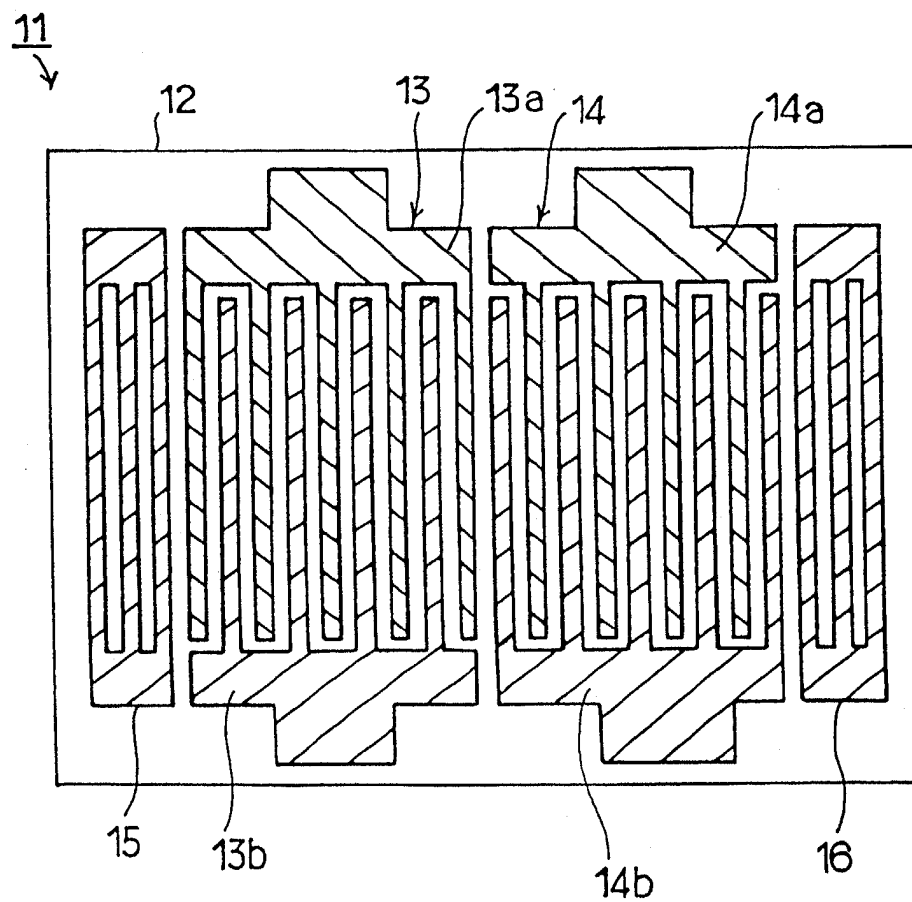


FIG. 1



096431.01302

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FIG. 2A

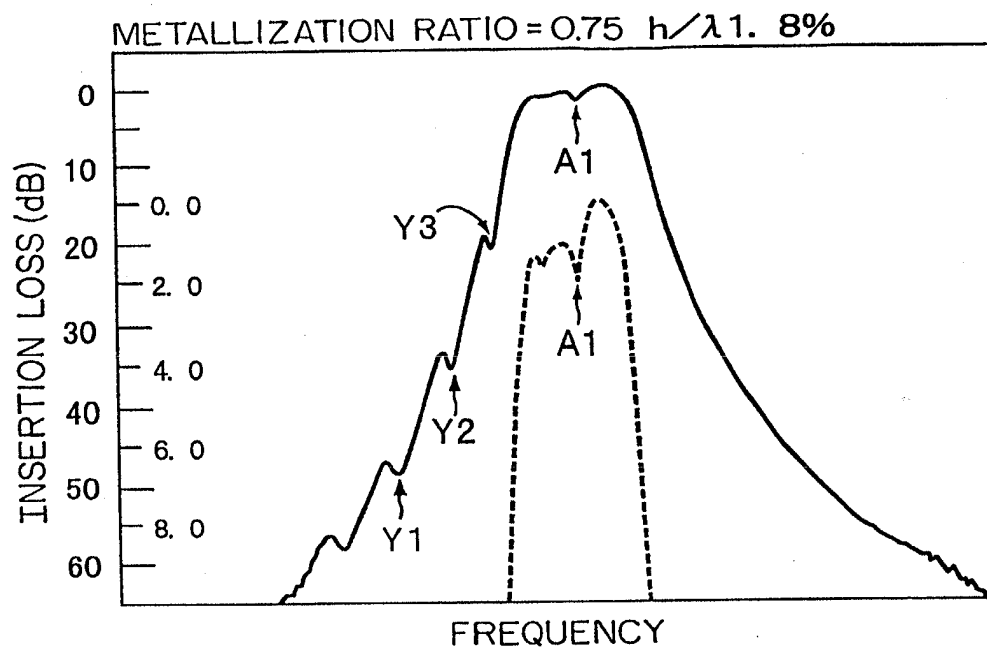
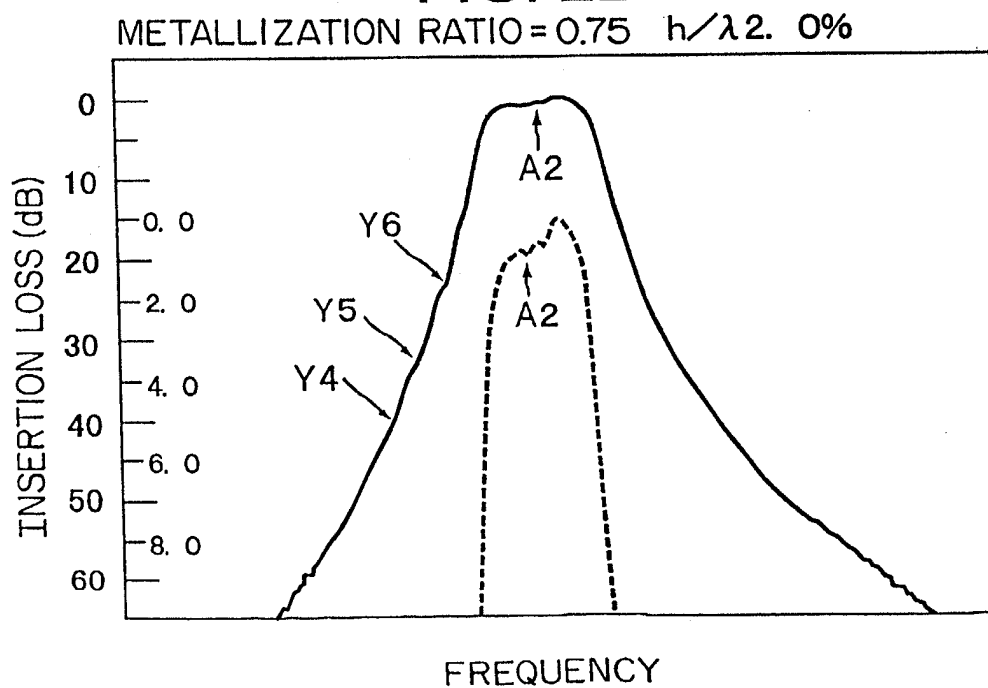


FIG. 2B



09564334.042002

FIG. 3A

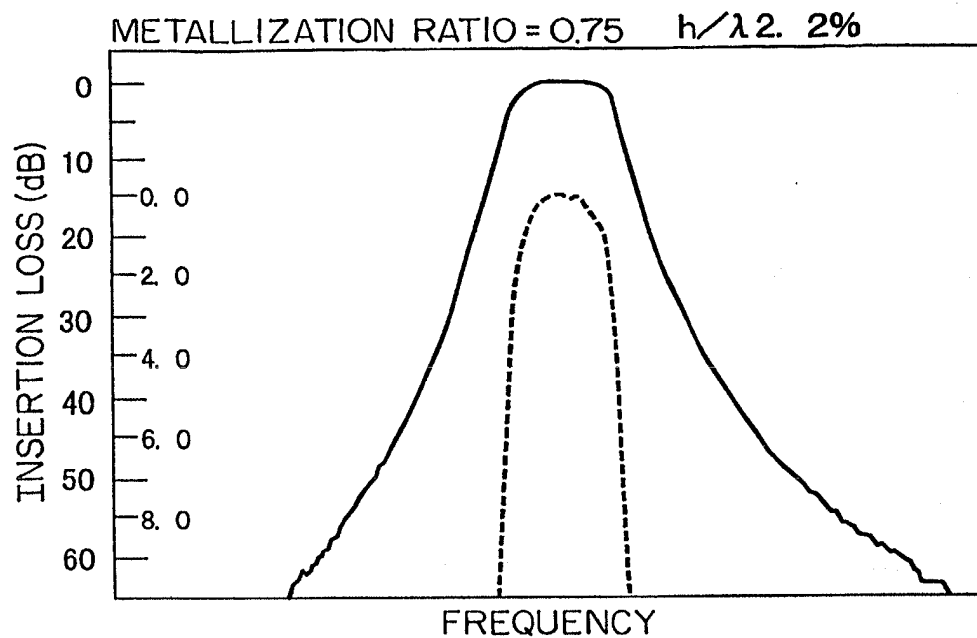


FIG. 3B

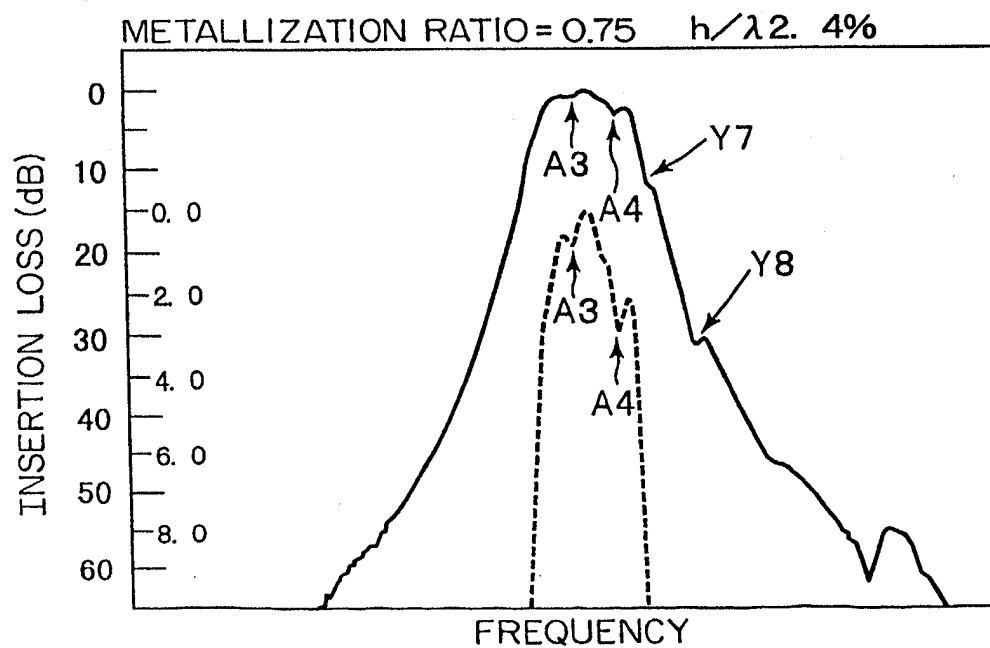


FIG. 4

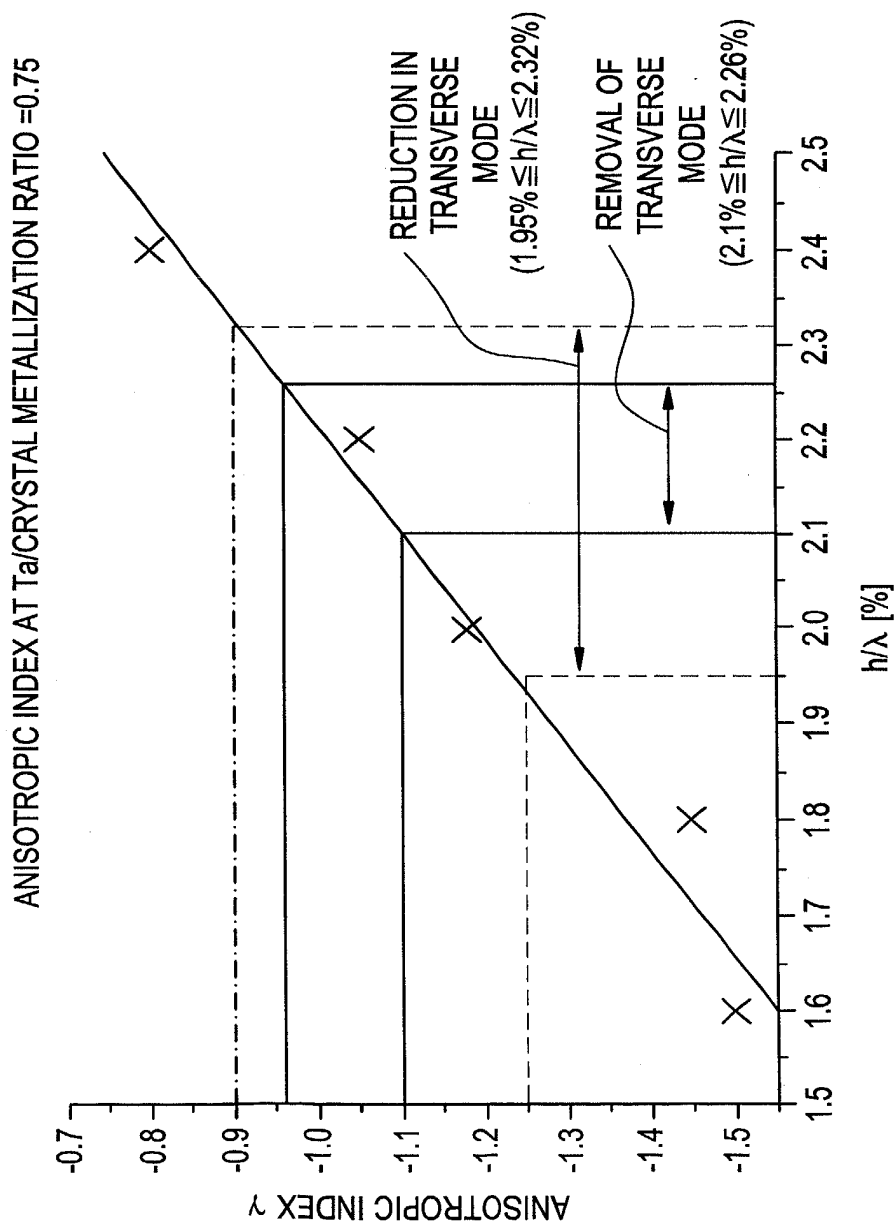
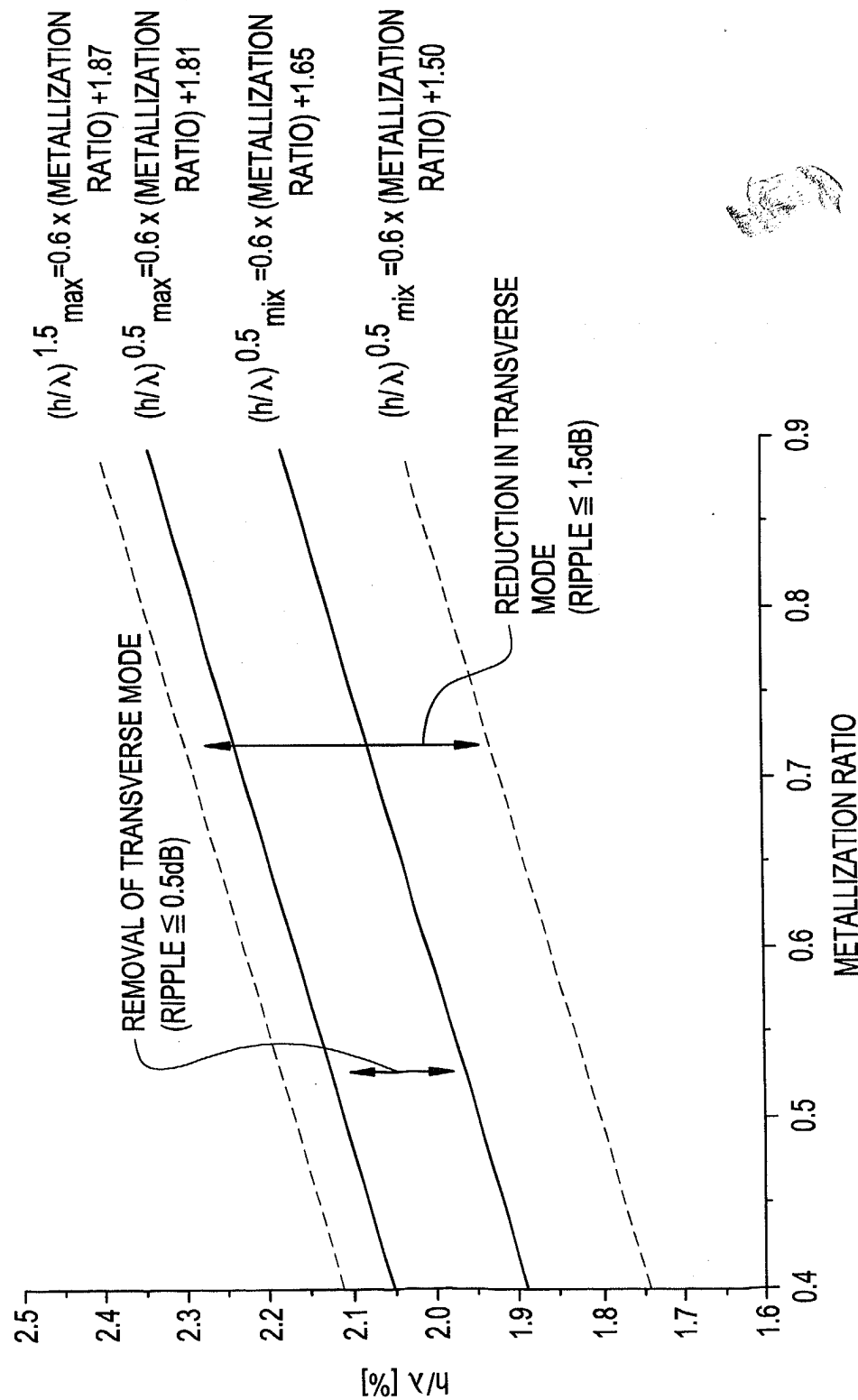


FIG. 5

RANGE WHERE RIPPLE CAUSED BY TRANSVERSE-MODE WAVE CAN BE REDUCED



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FIG. 6A

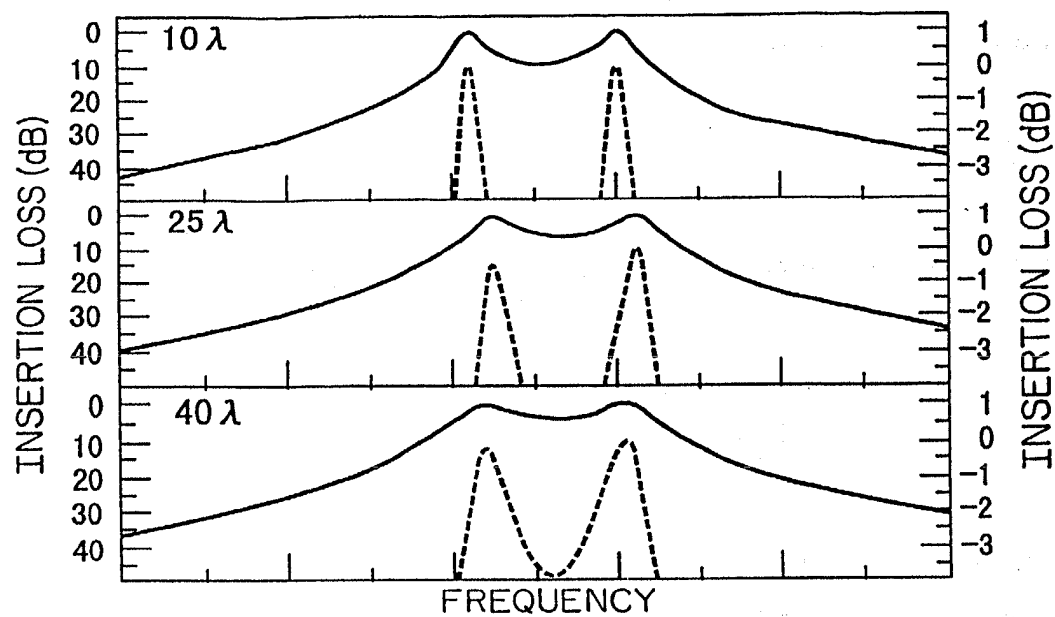


FIG. 6B

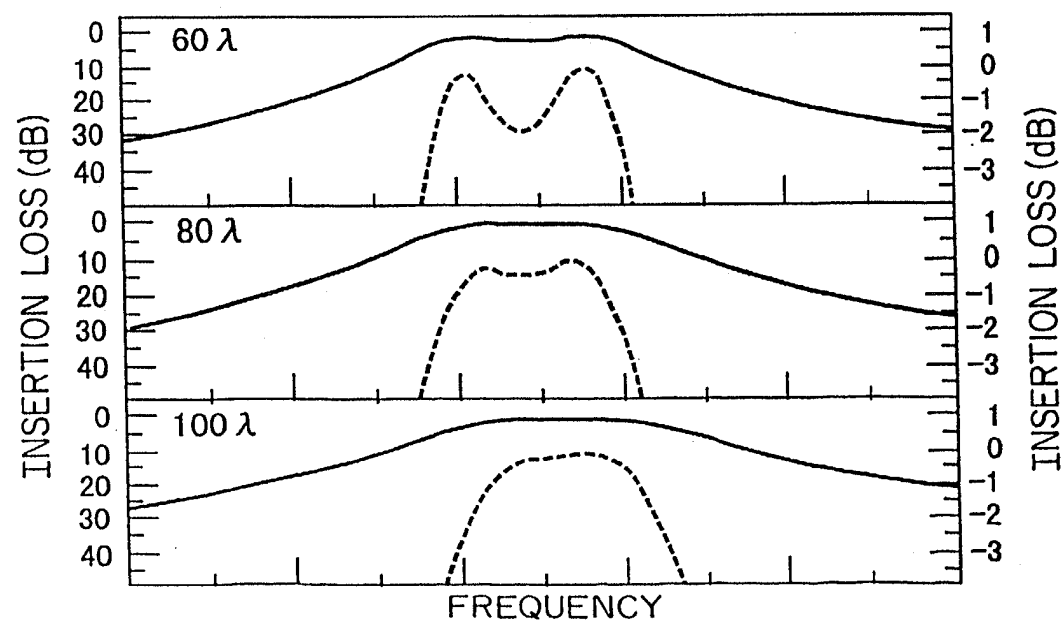


FIG. 7

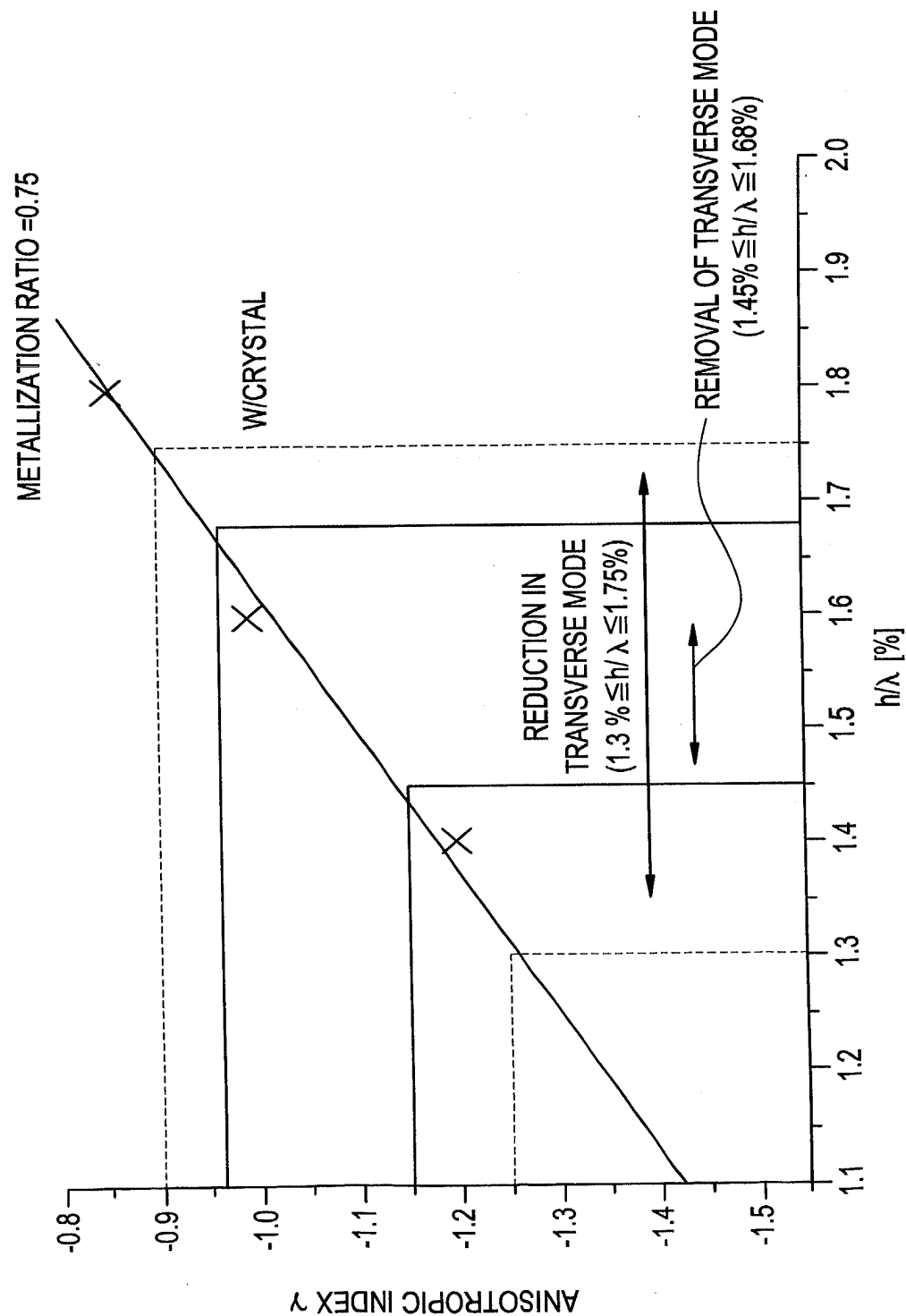


FIG. 8

RANGE WHERE RIPPLE CAUSED BY TRANSVERSE-MODE WAVE CAN BE REDUCED
(W-IDT / CRYSTAL)

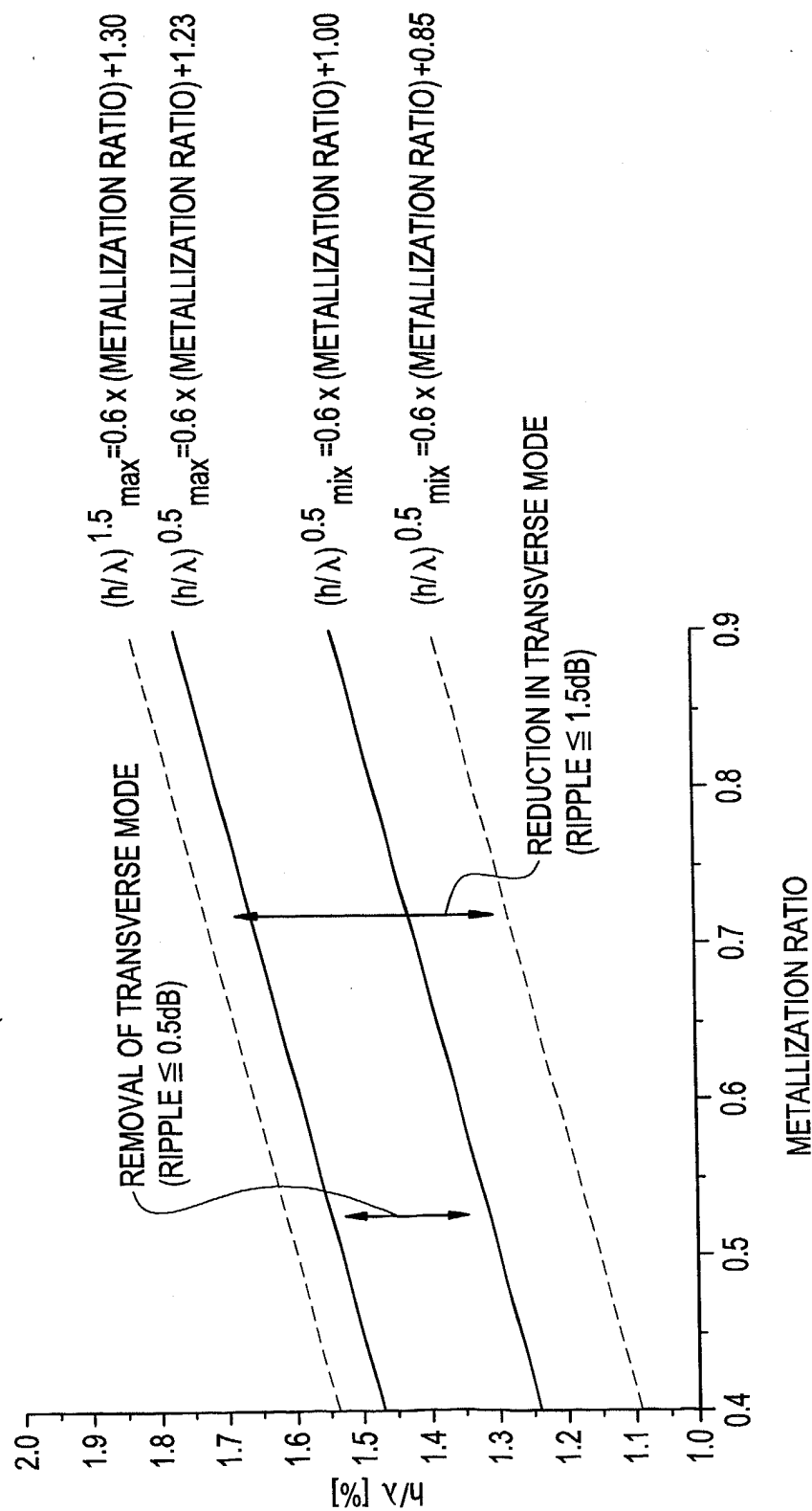
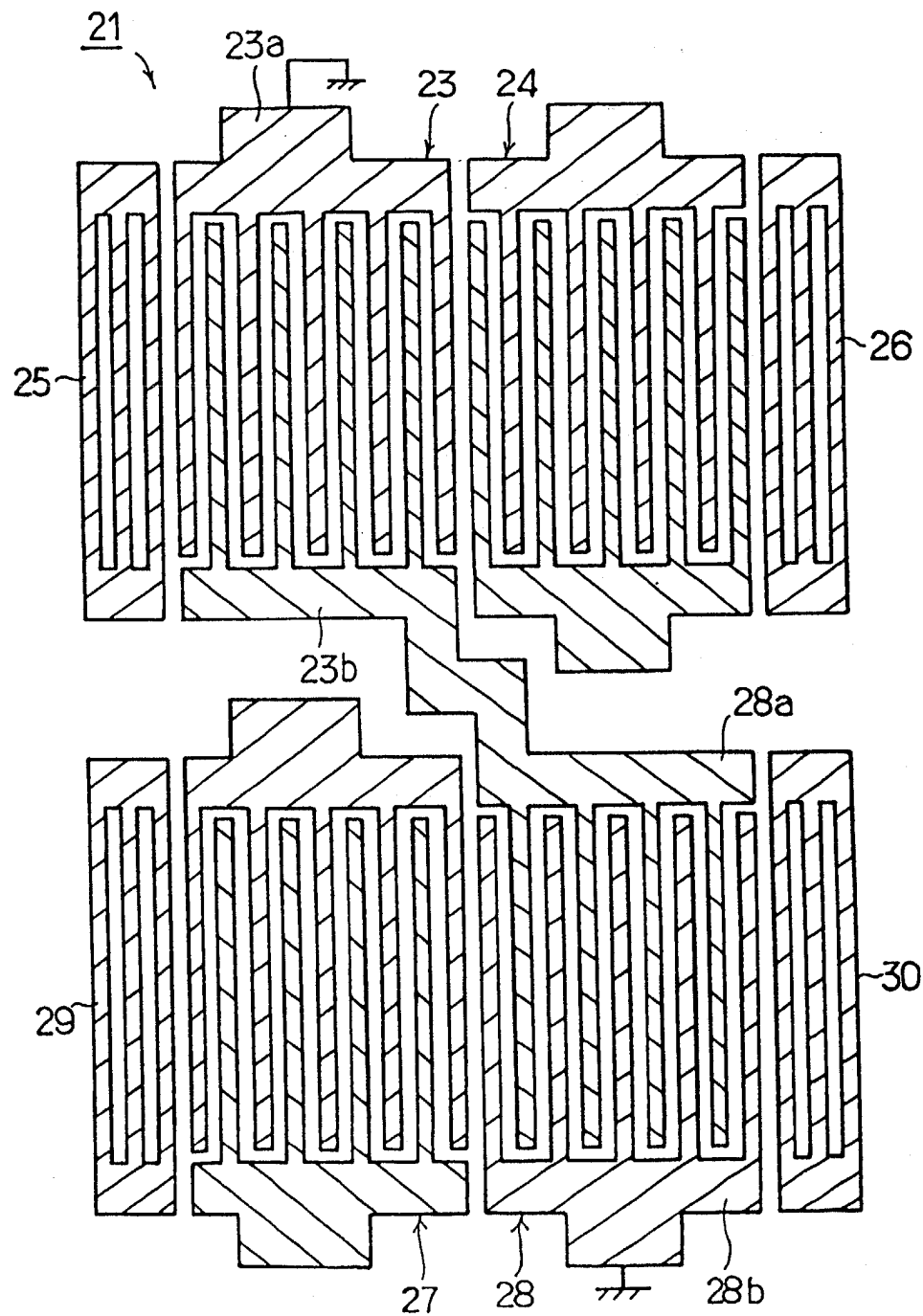


FIG. 9



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FIG. 10

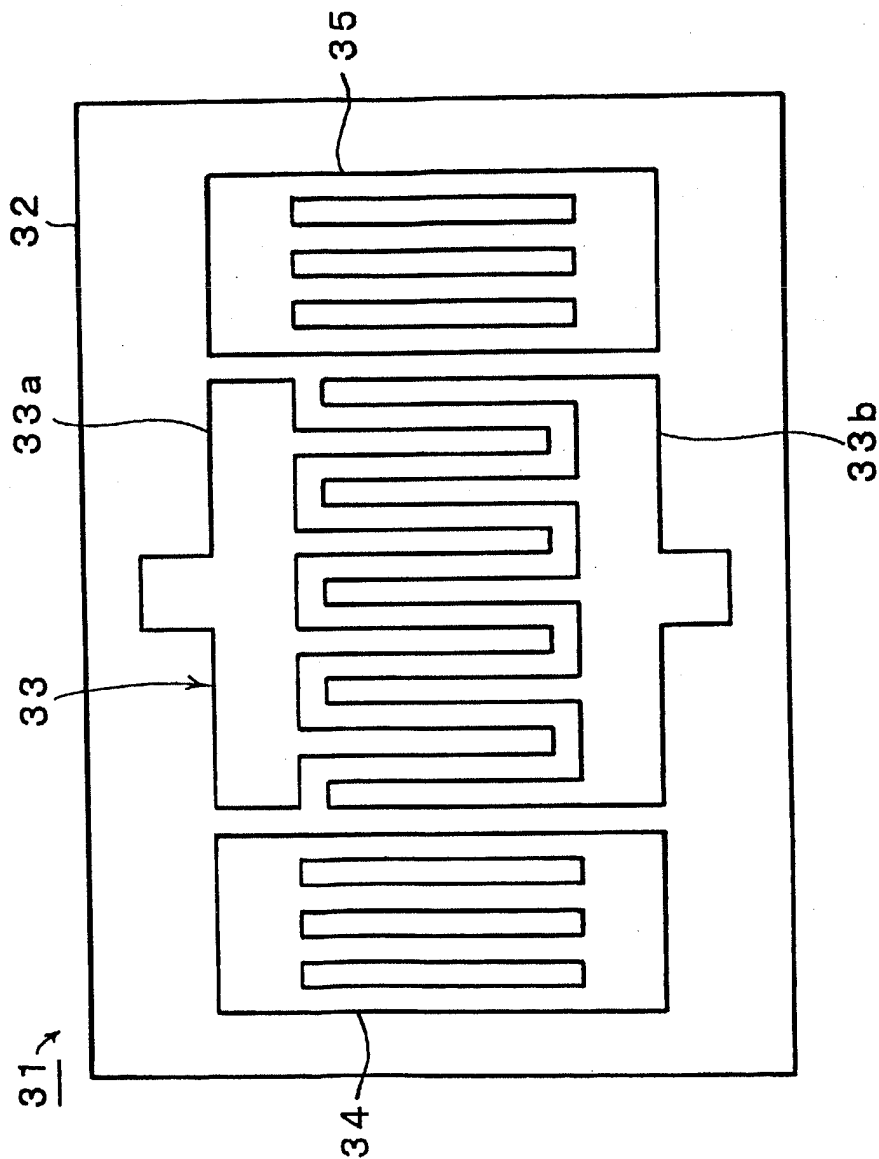


FIG. 11

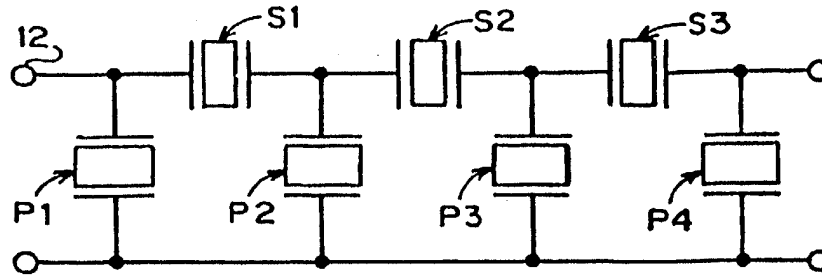
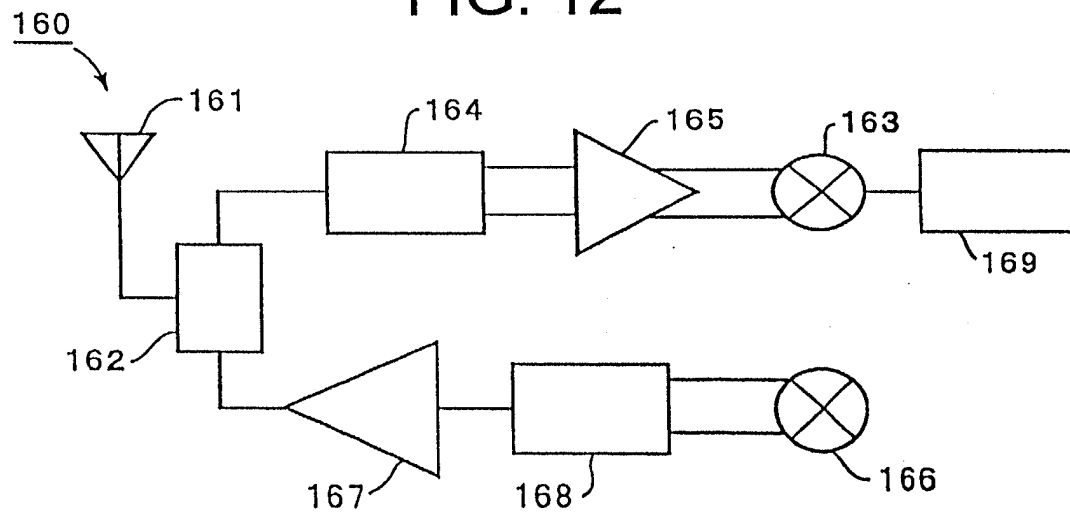


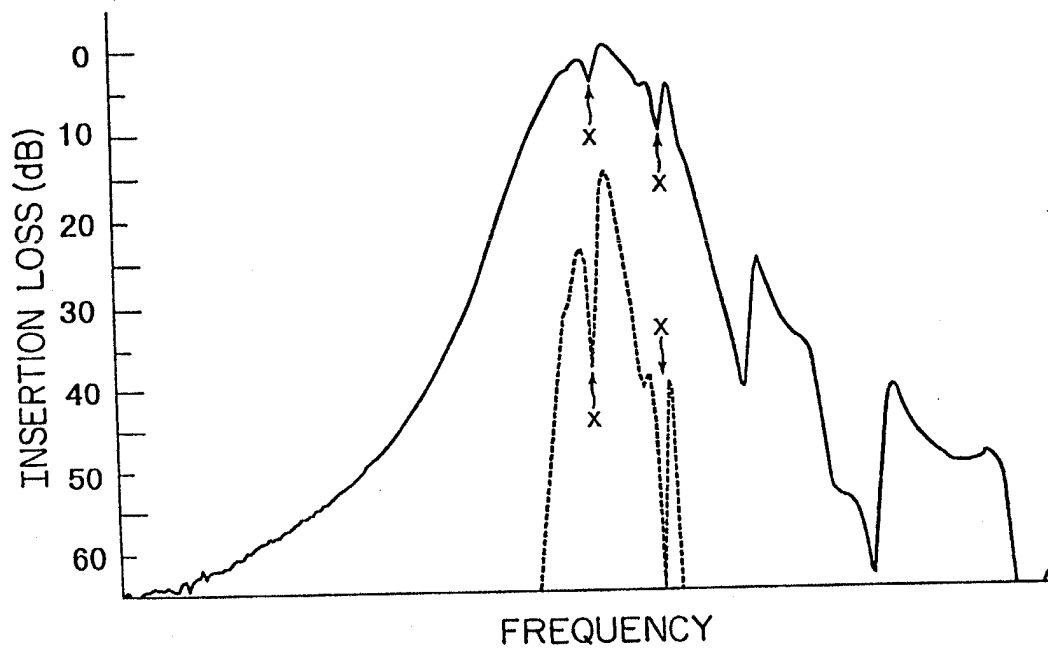
FIG. 12



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FIG. 13

METALLIZATION RATIO = 0.75 h/λ_2 50%



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